

Notice of References Cited	Application/Control No. 10/620,227	Applicant(s)/Patent Under Reexamination ZENKER ET AL.	
	Examiner Matthew D. Matzek	Art Unit 1771	Page 1 of 1

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	B	US-2,161,539	06-1939	SWARTZ THOMAS J	139/383R
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	U	
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	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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